


<b>Search Notes</b>  	<b>Application/Control No.</b>  10621250	<b>Applicant(s)/Patent Under Reexamination</b>  LEE ET AL.
	<b>Examiner</b>  Moon, Seokyun	<b>Art Unit</b>  2629

SEARCHED			
Class	Subclass	Date	Examiner
345	87	7/21/2007	s.m.
	89	7/21/2007	s.m.
	94	7/21/2007	s.m.
	95	7/21/2007	s.m.

SEARCH NOTES		
Search Notes	Date	Examiner
EAST (US-PGPUB,USPAT,JPO,EPO) Class 345 - Combined with Text Search	7/23/2007	s.m.
EAST (US-PGPUB,USPAT,JPO,EPO) Text Search - See Attachment for Search History	7/23/2007	s.m.

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner